

FQD24N08 / FQU24N08

# 80V N-Channel MOSFET

### **General Description**

These N-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for low voltage applications such as automotive, high efficiency switching for DC/DC converters, and DC motor control.

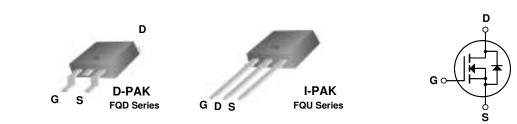
### Features

- 19.6A, 80V,  $R_{DS(on)}$  = 0.06 $\Omega$  @V\_{GS} = 10 V
- Low gate charge (typical 19 nC)
- Low Crss (typical 50 pF)
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability
- RoHS Compliant



January 2009

**OFE** 



## Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD24N08 / FQU24N08	Units
V <sub>DSS</sub>	Drain-Source Voltage		80	V
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	°C)	19.6	А
	- Continuous (T <sub>C</sub> = 10	O°C)	12.4	А
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	78.4	Α
V <sub>GSS</sub>	Gate-Source Voltage		± 25	V
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	230	mJ
I <sub>AR</sub>	Avalanche Current	(Note 1)	19.6	А
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	6.5	V/ns
PD	Power Dissipation ( $T_A = 25^{\circ}C$ ) *		2.5	W
	Power Dissipation ( $T_C = 25^{\circ}C$ )		50	W
	- Derate above 25°C		0.4	W/°C
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

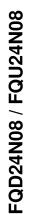
### **Thermal Characteristics**

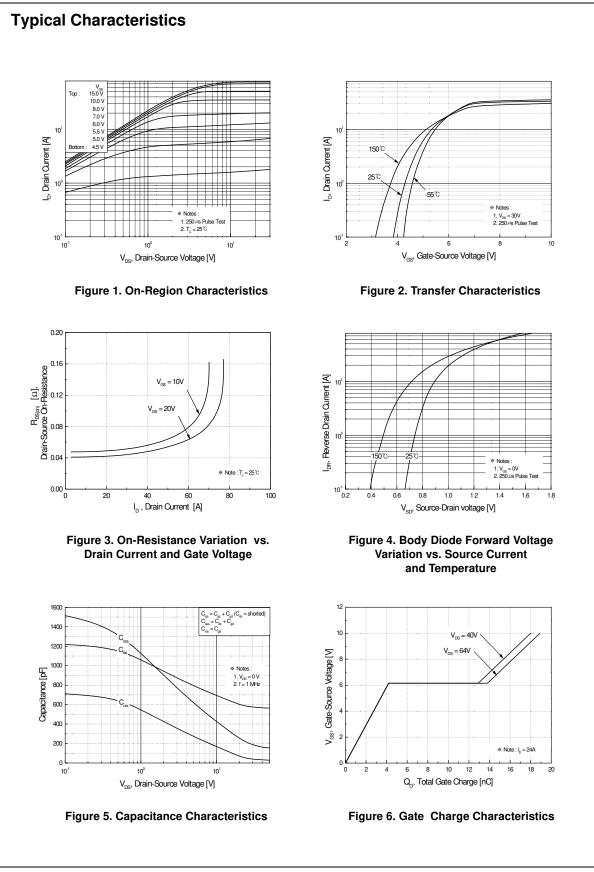
Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient *		50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		110	°C/W

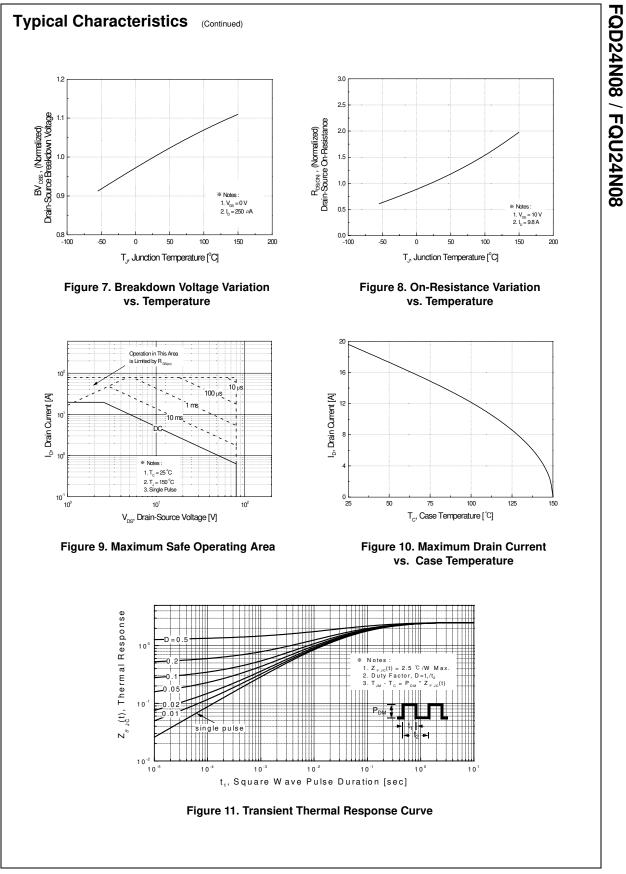
Symbol	Parameter	Test Conditions		Min	Тур	Max	Units
Off Cha	racteristics						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA		80			V
ΔBV <sub>DSS</sub> ΔΤ <sub>J</sub>	Breakdown Voltage Temperature Coefficient	$I_D = 250 \ \mu A$ , Referenced to	25°C		0.08		V/°C
I <sub>DSS</sub>		$V_{DS} = 80 \text{ V}, V_{GS} = 0 \text{ V}$				1	μA
	Zero Gate Voltage Drain Current	$V_{DS} = 64 \text{ V}, \text{ T}_{C} = 125^{\circ}\text{C}$				10	μA
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -25 \text{ V}, \text{ V}_{DS} = 0 \text{ V}$				-100	nA
On Cha	racteristics						
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$		2.0		4.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = 10 \text{ V}, \text{ I}_{D} = 9.8 \text{ A}$			0.048	0.06	Ω
ĴFS	Forward Transconductance	$V_{DS} = 30 \text{ V}, \text{ I}_{D} = 9.8 \text{ A}$ (1	Note 4)		11.5		S
Dynami	c Characteristics						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> = 25 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz			580	750	pF
C <sub>oss</sub>	Output Capacitance				210	270	pF
C <sub>rss</sub>	Reverse Transfer Capacitance				50	65	pF
Switchi	ng Characteristics						
d(on)	Turn-On Delay Time	$V_{DD}$ = 40 V, I <sub>D</sub> = 24 A, R <sub>G</sub> = 25 Ω			10	30	ns
r	Turn-On Rise Time				105	220	ns
d(off)	Turn-Off Delay Time				30	70	ns
f	Turn-Off Fall Time	(No	ote 4, 5)		35	80	ns
ל <sup>g</sup>	Total Gate Charge	V <sub>DS</sub> = 64 V, I <sub>D</sub> = 24 A,			19	25	nC
ጋ <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = 10 V			4.2		nC
ე <sub>gd</sub>	Gate-Drain Charge	(No	ote 4, 5)		9.6		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings					
S	Maximum Continuous Drain-Source Dic	•				19.6	Α
SM	Maximum Pulsed Drain-Source Diode F	Forward Current				78.4	Α
/ <sub>SD</sub>	Drain-Source Diode Forward Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 19.6 A				1.5	V
	Reverse Recovery Time	$V_{GS} = 0 V, I_{S} = 24 A,$			63		ns
ג <sub>rr</sub>	Reverse Recovery Charge	dI <sub>F</sub> / dt = 100 A/µs <sup>(1</sup>	Note 4)		130		nC
V <sub>SD</sub> frr Q <sub>rr</sub>	Reverse Recovery Time	$V_{GS} = 0 V, I_{S} = 24 A,$	Note 4)		63		ns
L = 0.82mH, I <sub>SD</sub> ≤ 24A, o Pulse Test :	ating : Pulse width limited by maximum junction temper $I_{AS}=19.6A, V_{DD}=25V, R_G=25 \Omega, Starting T_J=25^\circ, if did \leq 300A/us, V_{DD}\leq BVDSS, Starting T_J=25^\circC Pulse width \leq 300µs, Duty cycle \leq 2% adependent of operating temperature$						

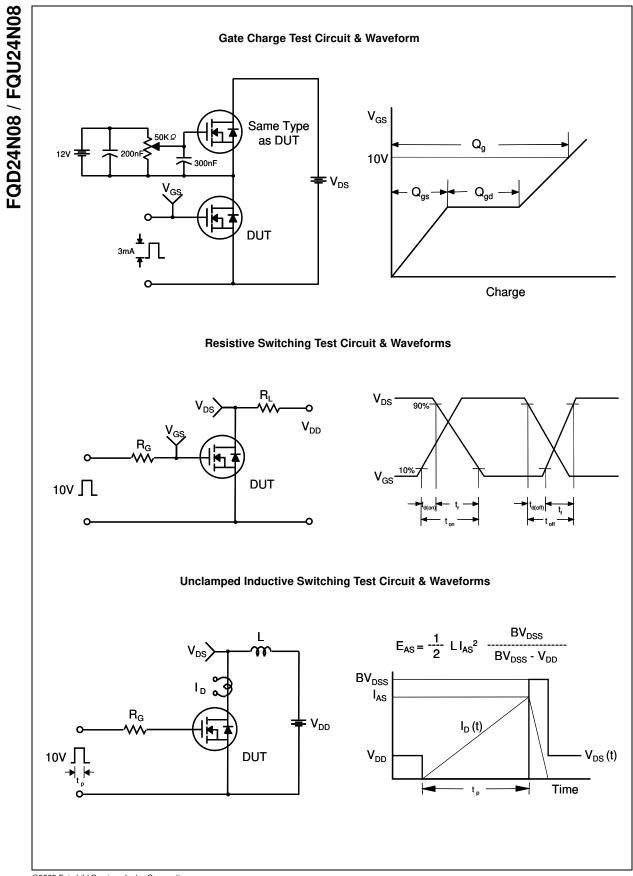
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Rev. A1. January 2009

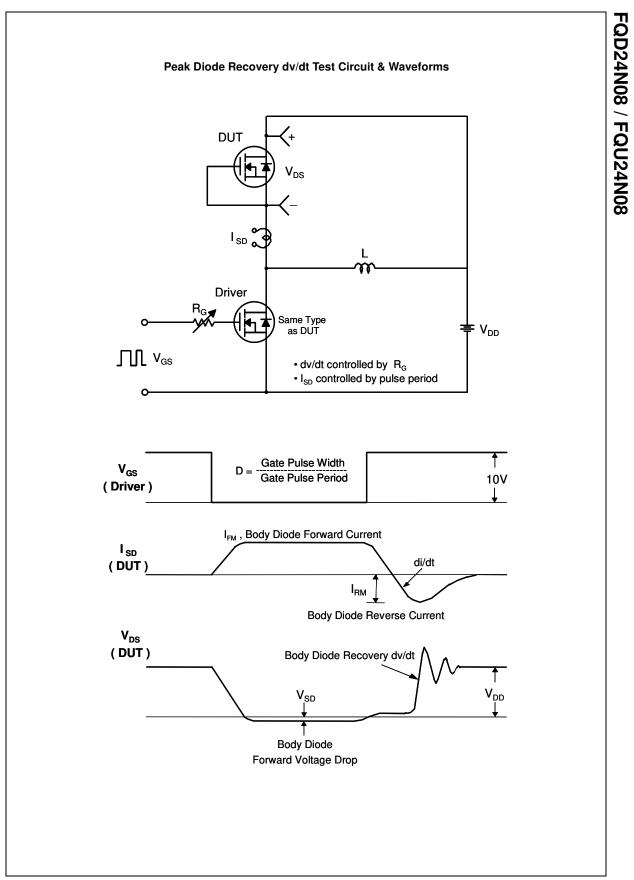


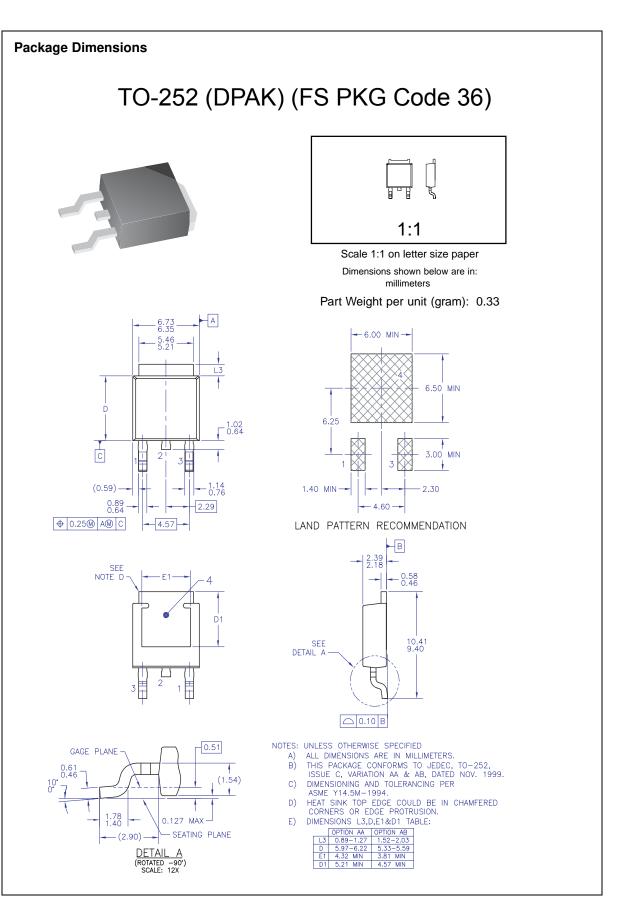


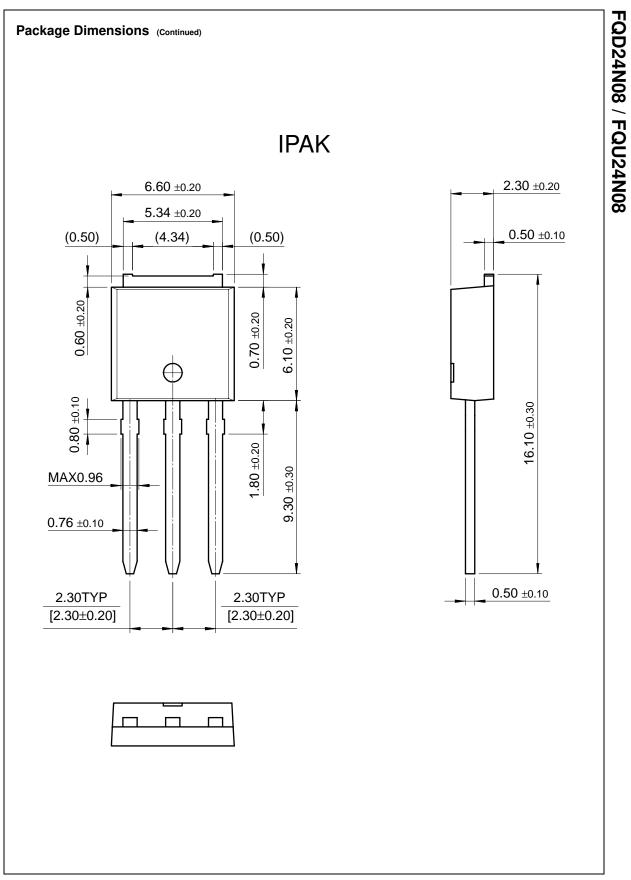




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